

تۛ / Descriptions

[illegible]

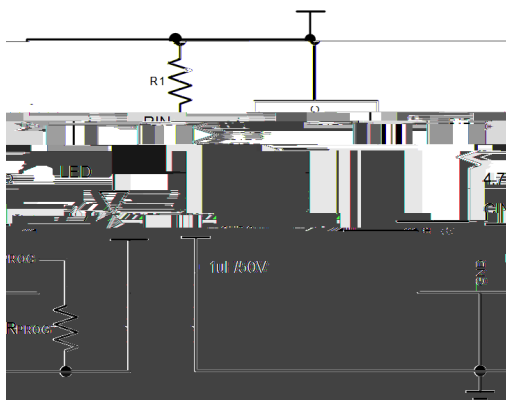
- / Features

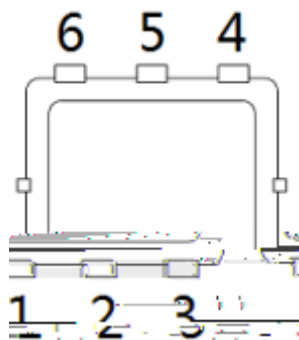
[illegible]

z v / Applications

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 X ɔ ɹ ă ɔ ʔH^H "
 ɓ w ɹ ɪ
 ʔH Ė 'Y ɓ ɪ

ϵ / Application Circuit





PIN Num.	Symbol	Function
		⌂
		⌂
		⌂
		⌂
	QF	⌂
	SURJ	⌂

PARAMETER	SYMBOL	RATINGS	UNITS
			†
			†
			†
			†

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
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תצ"ח א ה

[illegible]
$$7 \text{ W } \mathfrak{f} \approx \wedge \bar{\mathbf{I}}$$

E Â Û i [OBJ] д я i " Ö @ i X h λ γ δ ϰ Â Û i f i' s Ⴃ E δ - ဝ i
X သှ ဉ်း H i X သှ ~ Q Ä D b ' Â Û သှ я нъ i X သှ ဟ ဖု L X သှ W Ä p % W Ä i i
 ω Ⴃ ၁ [OBJ] λ γ X သှ သ L i Q A E သှ - သှ я i " G ဉ် W Q ဖ ဖု သှ L X သှ E
Â Û သှ я i " @ i H i X သှ ဟ ဖု ö L W Ä i T A λ γ [OBJ] X သှ သ L q ω Ⴃ λ သှ - E Â
Û i غ ω λ || X သှ я ε ζ H i ဖု ö я W Ä i X သှ သ L Ä D i j E X သှ သ L i
j λ γ Ö [OBJ] H i X သှ ~ Q j

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BRCL4079YT-4.2



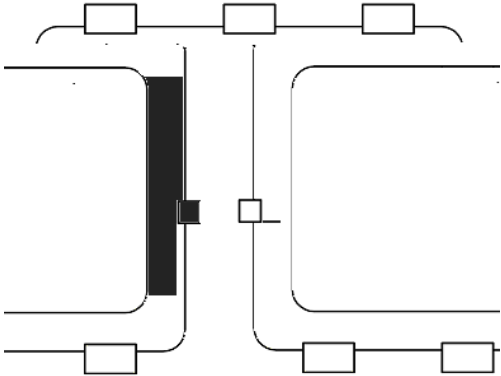
蓝箭电子
BLUE ROCKET ELECTRONICS

DATA SHEET

~ H 1²

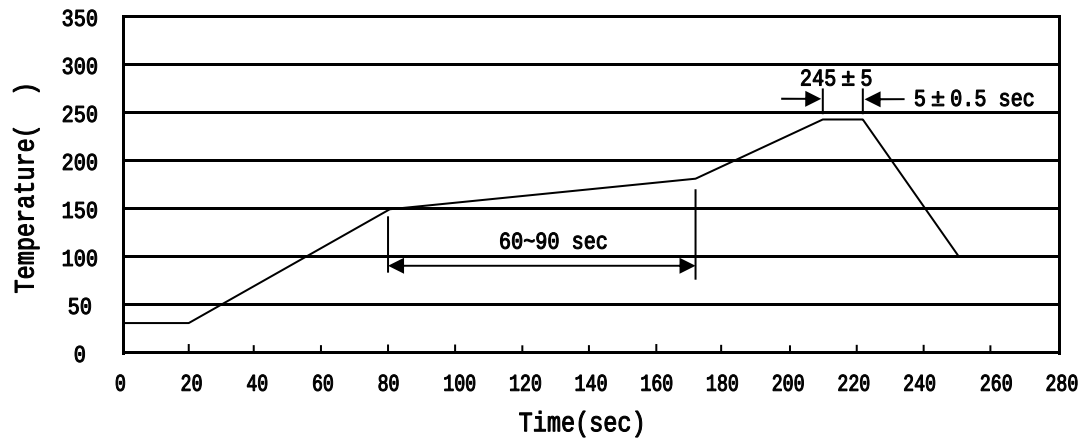
BRCL4079YT-4.2

4. 1. 2 / Marking Instructions



EU	
73: <075	

温度冲击试验 / Whp shudwxuh Suriloh i ru LU Uhior z Vroghulqj+Se0luhh,



试验程序

1. 将样品放入试验箱中。

2. 将温度升至 150°C 并保温 60-90 秒。

3. 将温度升至 245 ± 5°C 并保温 5 ± 0.5 秒。

4. 将样品放入试验箱中 / Resistance to Soldering Heat Test Conditions

将样品放入试验箱中。

5. 将样品放入试验箱中 / Packaging SPEC.

将样品放入试验箱中。

6. 将样品放入试验箱中 / Notices

将样品放入试验箱中。